

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/573,600	WILSON ET AL.	
Examiner	Art Unit	
lanet I Enns-Ford	1633	

	SEARCHED					
Class	Subclass	Date	Examiner			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STIC sequence search of SEQ ID NO: 3 and 123	7/28/2008	JLE		
EAST-text search	8/1/2008	JLE		